

Search Notes



Application/Control No.

10/049,626

Examiner

Frank W. Lu

Applicant(s)/Patent under Reexamination

MARUYAMA ET AL.

Art Unit

1634

SEARCHED

Class	Subclass	Date	Examiner.
435	6 1.31 1.32	8/5/2005	ru
	1.33		
	1.34		
	1.35		
	1.36		
	1.37		
	91.1		
	91.2		
	183		
436	44		
536	23.1		
	24.3		
	24.33		
	253		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

STN	DATE	EXMR
East (see attached file)	8/5/2005	ru
Inventor Searches		